EcoSPARK® Ignition IGBT

300 mJ, 400 V, N-Channel Ignition IGBT

Features

- SCIS Energy = 300 mJ at $T_J = 25$ °C
- Logic Level Gate Drive
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Automotive Ignition Coil Driver Circuits
- High Current Ignition System
- Coil on Plug Application

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit	
BV _{CER}	Collector to Emitter Breakdown Voltage (IC = 1 mA)	400	V	
BV _{ECS}	Emitter to Collector Voltage – Reverse Battery Condition (IC = 10 mA)			
E _{SCIS25}	ISCIS = 14.2 A, L = 3.0 mHy, RGE = 1 KΩ, T_C = 25°C (Note 1)			
E _{SCIS150}	ISCIS = 10.6 A, L = 3.0 mHy, RGE = 1 K Ω , T $_{\rm C}$ = 150°C (Note 2)	170	mJ	
IC25	Collector Current Continuous 21 at VGE = 4.0 V, T _C = 25°C		Α	
IC110	Collector Current Continuous at VGE = 4.0 V, T _C = 110°C	17	Α	
V_{GEM}	Gate to Emitter Voltage Continuous	±10	V	
PD	PD Power Dissipation Total, T _C = 25°C		W	
	Power Dissipation Derating, $T_C > 25^{\circ}C$	1	W/°C	
T _J , T _{STG}	Operating Junction and Storage Temperature	–55 to +175	ç	
TL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			
T _{PKG}	Reflow Soldering according to JESD020C	260	ç	
ESD	ESD HBM-Electrostatic Discharge Voltage at 100 pF, 1500 Ω		kV	
	CDM–Electrostatic Discharge Voltage at 1 Ω	2	kV	

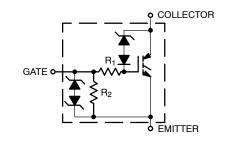
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Self clamped inductive Switching Energy (ESCIS25) of 300 mJ is based on the test conditions that is starting T_J = 25°C, L = 3 mHy, ISCIS = 14.2 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.
- Self Clamped inductive Switching Energy (ESCIS150) of 170 mJ is based on the test conditions that is starting T_J = 150°C, L = 3mHy, ISCIS = 10.6 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.



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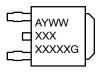






DPAK3 CASE 369AS D²PAK-3 CASE 418AJ

MARKING DIAGRAM



A = Assembly Location

Y = Year

WW = Work Week

XXXX = Device Code

G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

THERMAL RESISTANCE RATINGS

Characteristic		Max	Units
Junction-to-Case - Steady State (Drain)	$R_{ heta JC}$	1	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Test Conditions		Min	Тур.	Max.	Units
OFF CHARA	ACTERISTICS						
BV _{CER}	Collector to Emitter Breakdown Voltage	$I_{CE} = 2$ mA, $V_{GE} = 0$ V, $R_{GE} = 1$ k Ω , $T_{J} = -40$ to 150°C		370	400	430	V
BV _{CES}	Collector to Emitter Breakdown Voltage	I_{CE} = 10 mA, V_{GE} = 0 V, R_{GE} = 0, T_{J} = -40 to 150°C		390	420	450	V
BV _{ECS}	Emitter to Collector Breakdown Voltage	$I_{CE} = -75 \text{ mA}, V_{GE} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$		30	-	-	V
BV _{GES}	Gate to Emitter Breakdown Voltage	$I_{GES} = \pm 2 \text{ mA}$		±12	±14	_	V
I _{CER}	Collector to Emitter Leakage Current	V _{CE} = 175 V	T _J = 25°C	_	-	25	μΑ
		$R_{GE} = 1 \text{ k}\Omega$	T _J = 150°C	_	-	1	mA
I _{ECS}	Emitter to Collector Leakage Current	V _{EC} = 24 V	T _J = 25°C	-	-	1	mA
			T _J = 150°C	-	-	40	
R ₁	Series Gate Resistance		•	-	70	-	Ω
R ₂	Gate to Emitter Resistance			10K	-	26K	Ω
ON CHARAC	CTERISTICS						
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I _{CE} = 6 A, V _{GE} = 4 V, T _J = 25°C		-	1.25	1.65	V
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I _{CE} = 10 A, V _{GE} = 4.5 V, T _J = 150°C		-	1.58	1.80	V
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I _{CE} = 15 A, V _{GE} = 4.5 V, T _J = 150°C		-	1.90	2.20	V
OYNAMIC C	HARACTERISTICS					•	
Q _{G(ON)}	Gate Charge	I _{CE} = 10 A, V _{CE} = 12 V, V _{GE} = 5 V		_	17	-	nC
V _{GE(TH)}	Gate to Emitter Threshold Voltage	I _{CE} = 1 mA V _{CE} = V _{GE}	T _J = 25°C	1.3	-	2.2	V
			T _J = 150°C	0.75	-	1.8	
V_{GEP}	Gate to Emitter Plateau Voltage	V _{CE} = 12 V, I _{CE} = 10 A		_	3.0	_	V
WITCHING	CHARACTERISTICS						
td _{(ON)R}	Current Turn-On Delay Time-Resistive	$V_{CE} = 14 \text{ V}, R_L = 1 \Omega, \\ V_{GE} = 5 \text{ V}, R_G = 470 \Omega, \\ T_J = 25^{\circ}\text{C}$		-	0.7	4	μs
t _{rR}	Current Rise Time-Resistive			_	2.1	7	1
td _{(OFF)L}	Current Turn-Off Delay Time-Inductive	$V_{CE} = 300 \text{ V, L} = 1 \text{ mH,} $ $V_{GE} = 5 \text{ V, R}_{G} = 470 \Omega,$		-	4.8	15	
t _{fL}	Current Fall Time-Inductive	I _{CE} = 6.5 A, T _J = 25°C		_	2.8	15	1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

PACKAGE MARKING AND ORDERING INFORMATION

Device	Package	Shipping [†]
ISL9V3040D3ST-F085C	DPAK (Pb-Free)	2500 Units/Tape & Reel
ISL9V3040S3ST-F085C	D2PAK (Pb-Free)	800 Units/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

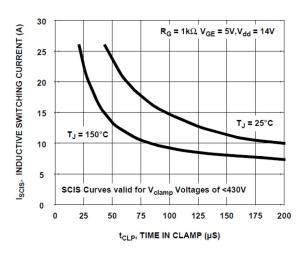


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

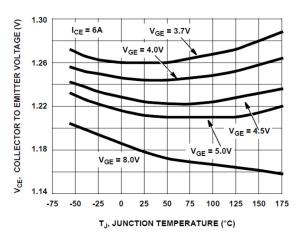


Figure 3. Collector to Emitter On–State Voltage vs. Junction Temperature

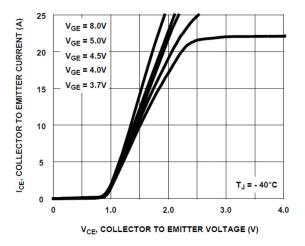


Figure 5. Collector to Emitter On-State Voltage vs. Collector Current

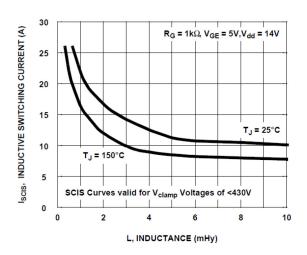


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

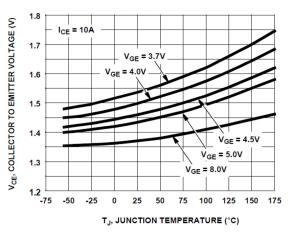


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

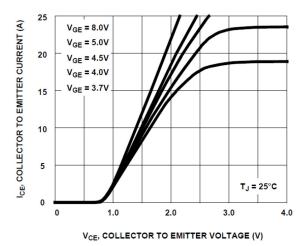


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

TYPICAL CHARACTERISTICS (continued)

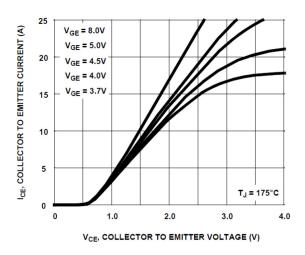


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

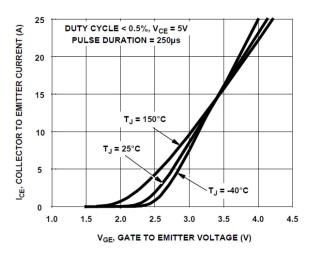


Figure 8. Transfer Characteristics

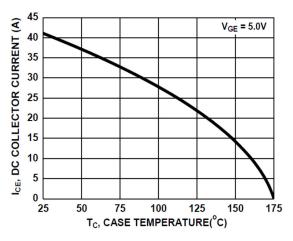


Figure 9. DC Collector Current vs. Case Temperature

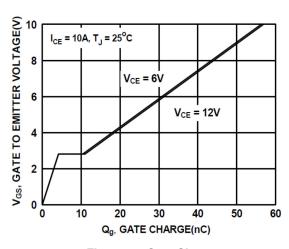


Figure 10. Gate Charge

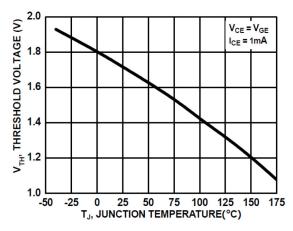


Figure 11. Threshold Voltage vs. Junction Temperature

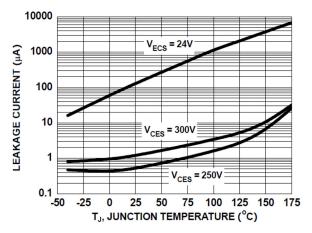
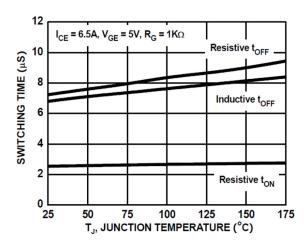


Figure 12. Leakage Current vs. Junction Temperature

TYPICAL CHARACTERISTICS (continued)



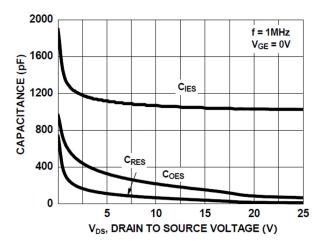


Figure 13. Switching Time vs. Junction Temperature

Figure 14. Capacitance vs. Collector to Emitter

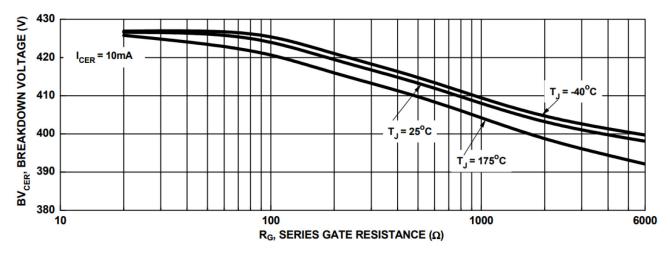


Figure 15. Break Down Voltage vs. Series Resistance

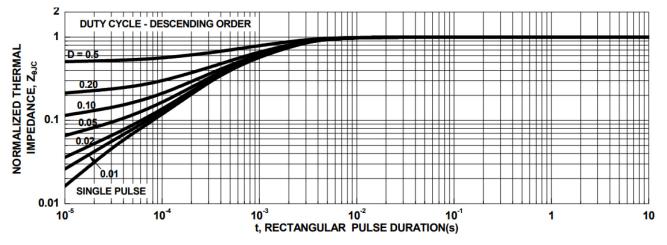


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

TEST CIRCUIT AND WAVEFORMS

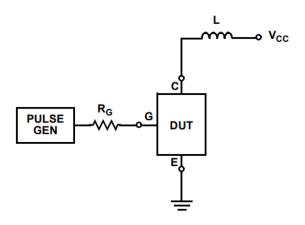


Figure 17. Inductive Switching Test Circuit

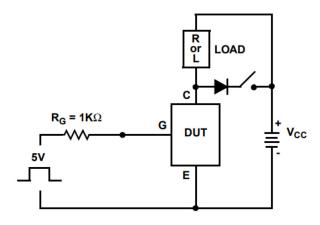


Figure 18. t_{ON} and t_{OFF} Switching Test Circuit

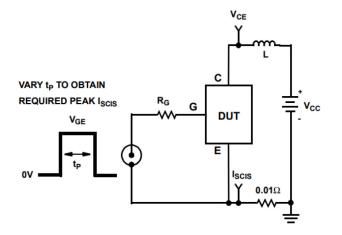


Figure 19. Energy Test Circuit

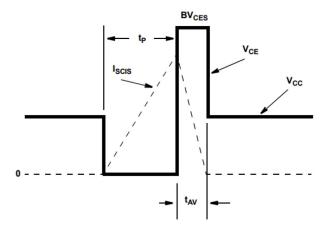
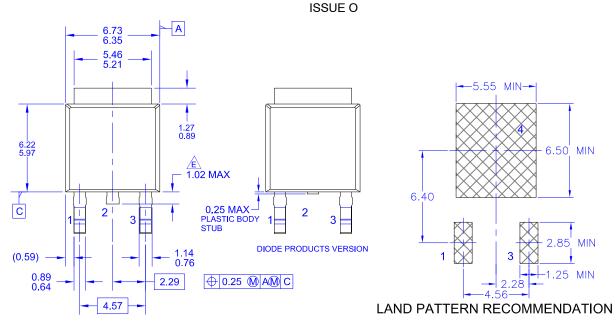


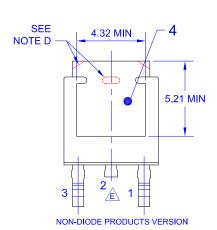
Figure 20. Energy Waveforms

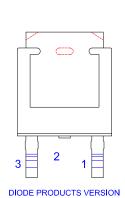
PACKAGE DIMENSIONS

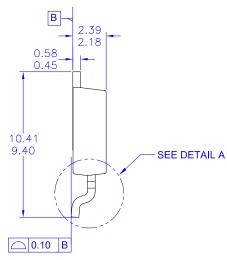
DPAK3 (TO-252 3 LD) CASE 369AS



NON-DIODE PRODUCTS VERSION



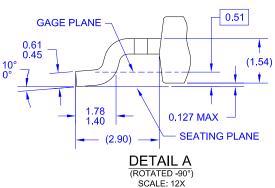




NOTES: UNLESS OTHERWISE SPECIFIED

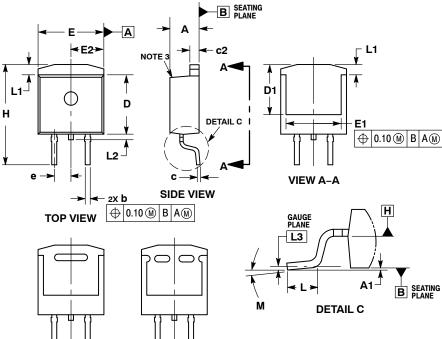
- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.

- B) ALL DIMENSIONS ARE IN MILLIMETERS.
 C) DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-2009.
 D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
- E) TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS
- F) DIMENSIONS ARE EXCLUSSIVE OF BURSS,
- MOLD FLASH AND TIE BAR EXTRUSIONS. G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.



PACKAGE DIMENSIONS

D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ ISSUE C

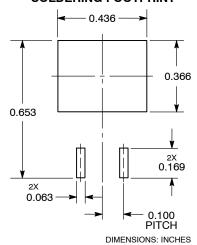


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
 3. CHAMFER OPTIONAL
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1 AND E1.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
b	0.020	0.039	0.51	0.99
С	0.012	0.029	0.30	0.74
c2	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260		6.60	
Е	0.380	0.420	9.65	10.67
E1	0.245		6.22	
е	0.100 BSC		2.54 BSC	
Н	0.575	0.625	14.60	15.88
L	0.070	0.110	1.78	2.79
L1		0.066		1.68
L2		0.070		1.78
L3	0.010 BSC		0.25 BSC	
М	-8°	8°	-8°	8°

RECOMMENDED SOLDERING FOOTPRINT*

VIEW A-A
OPTIONAL CONSTRUCTIONS



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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